

Notice of References Cited

Application/Control No.

10/594,436

Applicant(s)/Patent Under
Reexamination
YOSHITAKE ET AL.

Examiner

Kevin S. Orwig

Art Unit

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,035,899 A	07-1991	Saeki et al.	424/480
*	B	US-2002/0045184 A1	04-2002	Chen, Chih-Ming	435/6
*	C	US-6,444,689 B1	09-2002	Whittle et al.	514/338
*	D	US-2005/0163846 A1	07-2005	Aoki, Shigeru	424/472
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	WO 03/043661	05-2003	World Intellect	Aoki et al.	A61K 47/38
*	O	JP 2000/128779	05-2000	Japan	Nakajima et al.	A61K 9/48
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Machine translation of JP 2000/128779
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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